Product data sheet

1. General description

The 74LV00A is a quad 2-input NAND gate.

Inputs are overvoltage tolerant. This feature allows the use of these devices as translators in mixed voltage environments.

Schmitt-trigger action at all inputs makes the circuit tolerant of slower input rise and fall times.

This device is fully specified for partial power down applications using I_{OFF} . The I_{OFF} circuitry disables the output, preventing the potentially damaging backflow current through the device when it is powered down.

2. Features and benefits

- Wide supply voltage range from 2.0 V to 5.5 V
- Maximum t_{pd} of 9 ns at 5 V
- Typical $V_{OL(p)}$ < 0.8 V at V_{CC} = 3.3 V, T_{amb} = 25 °C
- Typical $V_{OH(v)} > 2.3 \text{ V}$ at $V_{CC} = 3.3 \text{ V}$, $T_{amb} = 25 \text{ °C}$
- Supports mixed-mode voltage operation on all ports
- I_{OFF} circuitry provides partial Power-down mode operation
- Latch-up performance exceeds 250 mA per JESD 78 Class II
- ESD protection:
 - HBM: ANSI/ESDA/JEDEC JS-001 class 3A exceeds 4000 V
 - CDM: ANSI/ESDA/JEDEC JS-002 class C3 exceeds 1000 V
- Specified from -40 °C to +85 °C and from -40 °C to +125 °C

3. Ordering information

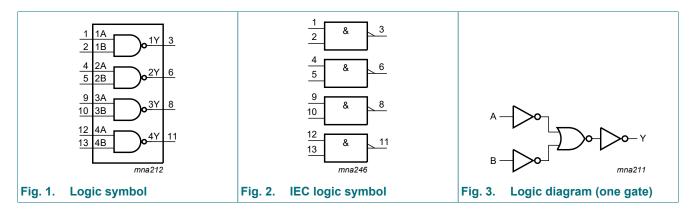
Table 1. Ordering information

Type number	Package						
	Temperature range	Name	Description	Version			
74LV00APW	-40 °C to +125 °C	TSSOP14	plastic thin shrink small outline package; 14 leads; body width 4.4 mm	SOT402-1			



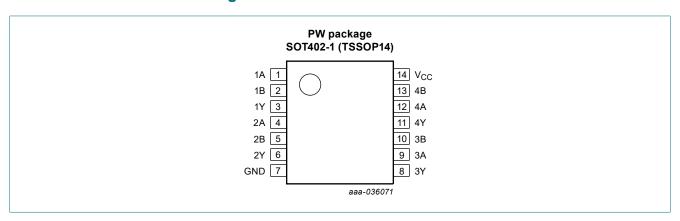
Quad 2-input NAND gate

4. Functional diagram



5. Pinning information

5.1. Pinning



5.2. Pin description

Table 2. Pin description

Symbol	Pin	Description
1A, 2A, 3A, 4A	1, 4, 9, 12	data input
1B, 2B, 3B, 4B	2, 5, 10, 13	data input
1Y, 2Y, 3Y, 4Y	3, 6, 8, 11	data output
GND	7 ground (0 V)	
V _{CC}	14	supply voltage

Quad 2-input NAND gate

6. Functional description

Table 3. Function table

 $H = HIGH \ voltage \ level; \ L = LOW \ voltage \ level; \ X = don't \ care.$

Input		Output
nA	nB	nY
L	X	Н
X	L	Н
Н	Н	L

7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{CC}	supply voltage			-0.5	+7.0	V
VI	input voltage		[1]	-0.5	+7.0	V
Vo	output voltage	output HIGH or LOW state	[2] [3]	-0.5	V _{CC} + 0.5	V
		output power-down	[2]	-0.5	+7.0	V
I _{IK}	input clamping current	V _I < 0 V		-20	-	mA
I _{OK}	output clamping current	V _O < 0 V		-50	-	mA
Io	output current	V _O = 0 V to V _{CC}		-	±35	mA
I _{CC}	supply current			-	70	mA
I _{GND}	ground current			-70	-	mA
T _{stg}	storage temperature			-65	+150	°C
P _{tot}	total power dissipation	T _{amb} = -40 °C to +125 °C	[4]	-	500	mW

^[1] If the input current ratings are observed, the minimum input voltage ratings may be exceeded.

^[2] If the output current ratings are observed, the output voltage ratings may be exceeded.

^[3] This value is limited to 7 V maximum.

^[4] For SOT402-1 (TSSOP14) package: P_{tot} derates linearly with 7.3 mW/K above 81 °C.

Quad 2-input NAND gate

8. Recommended operating conditions

Table 5. Recommended operating conditions

Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{CC}	supply voltage		2.0	5.0	5.5	V
VI	input voltage		0	-	5.5	V
Vo	output voltage	output HIGH or LOW state	0	-	V _{CC}	V
		output power-down	0	-	5.5	V
T _{amb}	ambient temperature		-40	+25	+125	°C
Δt/ΔV	input transition rise and fall rate	V _{CC} = 2.3 V to 2.7 V	-	-	200	ns/V
		V _{CC} = 3.0 V to 3.6 V	-	-	100	ns/V
		V _{CC} = 4.5 V to 5.5 V	-	-	20	ns/V

9. Static characteristics

Table 6. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	25 °C			-40 °C to +85 °C		-40 °C to +125 °C		Unit
			Min	Тур	Max	Min	Max	Min	Max	
V_{IH}	HIGH-level	V _{CC} = 2 V	1.5	-	-	1.5	-	-	-	V
	input voltage	V _{CC} = 2.3 V to 2.7 V	0.7V _{CC}	-	-	0.7V _{CC}	-	-	-	
		V _{CC} = 3.0 V to 3.6 V	0.7V _{CC}	-	-	0.7V _{CC}	-	-	-	V
		V _{CC} = 4.5 V to 5.5 V	0.7V _{CC}	-	-	0.7V _{CC}	-	-	-	V
V _{IL}	LOW-level	V _{CC} = 2 V	-	-	0.5	-	0.5	-	0.5	V
	input voltage	V _{CC} = 2.3 V to 2.7 V	-	-	0.3V _{CC}	-	0.3V _{CC}	-	0.3V _{CC}	V
		V _{CC} = 3.0 V to 3.6 V	-	-	0.3V _{CC}	-	0.3V _{CC}	-	0.3V _{CC}	V
		V _{CC} = 4.5 V to 5.5 V	-	-	0.3V _{CC}	-	0.3V _{CC}	-	0.3V _{CC}	V
V _{OH}	HIGH-level	V _I = V _{IH} or V _{IL}								
	output voltage	V _{CC} = 2.0 V to 5.5 V; I _O = -50 μA	V _{CC} -0.1	-	-	V _{CC} -0.1	-	V _{CC} -0.1	-	V
		V _{CC} = 2.3 V; I _O = -2 mA	2	-	-	2	-	2	-	V
		V _{CC} = 3.0 V; I _O = -6 mA	2.48	-	-	2.48	-	2.48	-	V
		V _{CC} = 4.5 V; I _O = -12 mA	3.8	-	-	3.8	-	3.8	-	٧
V_{OL}	LOW-level	V _I = V _{IH} or V _{IL}							1	
	output voltage	V _{CC} = 2.0 V to 5.5 V; I _O = 50 μA	-	-	0.1	-	0.1	-	0.1	V
		V _{CC} = 2.3 V; I _O = 2 mA	-	-	0.4	-	0.4	-	0.4	V
		V _{CC} = 3.0 V; I _O = 6 mA	-	-	0.44	-	0.44	-	0.44	V
		V _{CC} = 4.5 V; I _O = 12 mA	-	-	0.55	-	0.55	-	0.55	V
I _{OFF}	power-off leakage current	V_I or V_O = GND to 5.5 V; V_{CC} = 0 V	-	-	0.5	-	5	-	5	μΑ
l _l	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 0$ V to 5.5 V	-	-	±0.1	-	±1	-	±1	μΑ
I _{CC}	supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 5.5 \text{ V}$	-	-	2	-	20	-	20	μΑ

Quad 2-input NAND gate

10. Dynamic characteristics

Table 7. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V); for test circuit see Fig. 5.

Symbol	Parameter	Conditions		25 °C		-40 °C t	o +85 °C	-40 °C to	+125 °C	Unit
			Min	Typ[1]	Max	Min	Max	Min	Max	
t _{pd}	propagation	nA, nB to nY; see Fig. 4 [2]								
	delay	V _{CC} = 2.3 V to 2.7 V								
		C _L = 15 pF	-	5.7	12.9	1	15	1	16	ns
		C _L = 50 pF	-	7.8	16.6	1	20	1	21	ns
		V _{CC} = 3.0 V to 3.6 V								
		C _L = 15 pF	-	4.3	7.9	1	9.5	1	10.5	ns
		C _L = 50 pF	-	6.1	11.4	1	13	1	14	ns
		V _{CC} = 4.5 V to 5.5 V								
		C _L = 15 pF	-	3.4	5.5	1	6.5	1	7	ns
		C _L = 50 pF	-	4.8	7.5	1	8.5	1	9	ns
C _I	input capacitance	$V_I = V_{CC}$ or GND; $V_{CC} = 3.3 \text{ V}$	-	2	6	-	6	-	6	pF
Co	output capacitance	$V_O = V_{CC}$ or GND; $V_{CC} = 3.3 \text{ V}$	-	5.6	-	-	-	-	-	pF
C _{PD}	power dissipation	per buffer; $C_L = 50 \text{ pF}$; [3] f = 10 MHz; $V_I = GND \text{ to } V_{CC}$								
	capacitance	V _{CC} = 3.3 V	-	9.3	-	-	-	-	-	pF
		V _{CC} = 5.0 V	-	9.5	-	-	-	-	-	pF

- [1] Typical values are measured at T_{amb} = 25 °C and V_{CC} = 2.5 V, 3.3 V, and 5 V respectively, unless otherwise specified.
- t_{pd} is the same as t_{PLH} and t_{PHL} . C_{PD} is used to determine the dynamic power dissipation (P_D in μ W): $P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \sum (C_L \times V_{CC}^2 \times f_o)$ where:

f_i = input frequency in MHz;

f_o = output frequency in MHz;

C_L = output load capacitance in pF;

V_{CC} = supply voltage in V;

N = number of inputs switching;

 $\sum (C_L \times V_{CC}^2 \times f_o) = \text{sum of outputs.}$

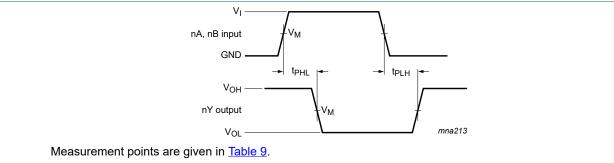
Table 8. Noise characteristics at T_{amb} = 25 °C

Voltages are referenced to GND (ground = 0 V); for test circuit see Fig. 5.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{OL(p)}$	LOW-level output voltage (peak)	$V_{CC} = 3.3 \text{ V}; C_L = 50 \text{ pF}$	-	0.2	0.8	V
$V_{OL(v)}$	LOW-level output voltage (valley)	$V_{CC} = 3.3 \text{ V}; C_L = 50 \text{ pF}$	-0.8	-0.1	-	V
$V_{OH(v)}$	HIGH-level output voltage (valley)	$V_{CC} = 3.3 \text{ V}; C_L = 50 \text{ pF}$	-	3.1	-	V
$V_{IH(AC)}$	AC HIGH-level input voltage	$V_{CC} = 3.3 \text{ V}; C_L = 50 \text{ pF}$	2.31	-	-	V
$V_{\text{IL}(AC)}$	AC LOW-level input voltage	V_{CC} = 3.3 V; C_L = 50 pF	-	-	0.99	V

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10.1. Waveforms and test circuit

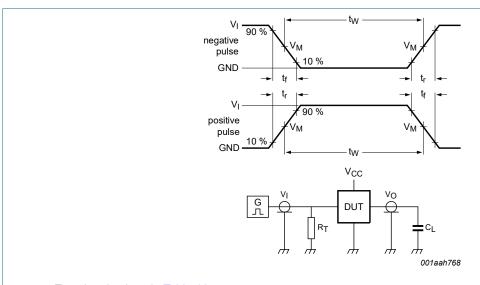


 V_{OL} and V_{OH} are typical voltage output levels that occur with the output load.

Fig. 4. Input (nA, nB) to output (nY) propagation delays

Table 9. Measurement points

Input	Output
V _M	V_{M}
0.5V _{CC}	0.5V _{CC}



Test data is given in Table 10.

Definitions test circuit:

R_T = Termination resistance should be equal to output impedance Z_o of the pulse generator;

C_L = Load capacitance including jig and probe capacitance.

Fig. 5. Test circuit for measuring switching times

Table 10. Test data

Input		Load	Test
V _I t _r , t _f		C _L	
GND to V _{CC}	3.0 ns	15 pF, 50 pF	t _{PLH} , t _{PHL}

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11. Package outline

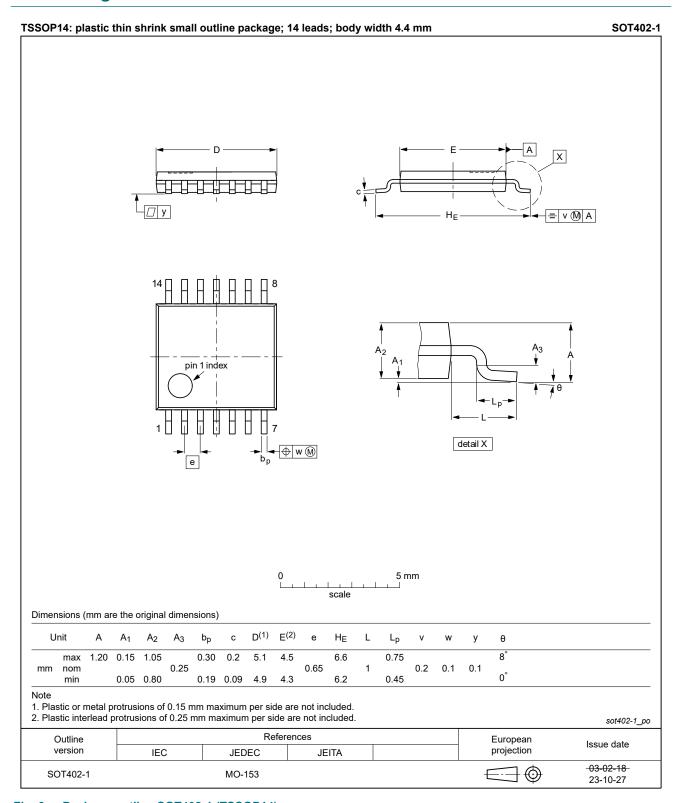


Fig. 6. Package outline SOT402-1 (TSSOP14)

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12. Abbreviations

Table 11. Abbreviations

Acronym	Description
ANSI	American National Standards Institute
CDM	Charge Device Model
DUT	Device Under Test
ESD	ElectroStatic Discharge
ESDA	ElectroStatic Discharge Association
НВМ	Human Body Model
JEDEC	Joint Electron Device Engineering Council

13. Revision history

Table 12. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74LV00A v.3.1	20240704	Product data sheet	-	74LV00A v.3
74LV00A v.3	20240129	Product data sheet	-	74LV00A v.2
Modifications:		Derating values for P _{tot} total ned TSSOP package outline		
74LV00A v.2	20231006	Product data sheet	-	74LV00A v.1
Modifications	Section 2: E	ESD specification updated a	ccording to the latest	JEDEC standard.
74LV00A v.1	20181219	Product data sheet	-	-

Quad 2-input NAND gate

14. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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